

7.6 Amps, 600Volts N-Channel MOSFET

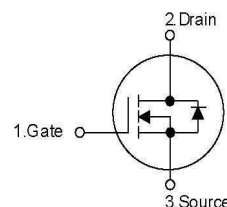
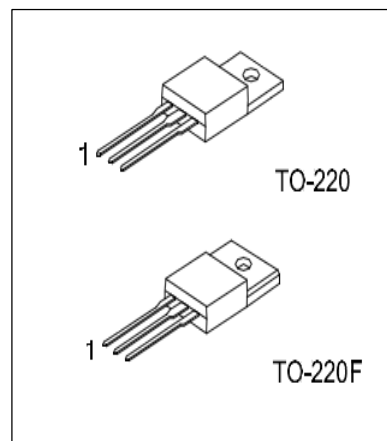
■ Description

The HX8N60 is a high voltage MOSFET and is designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and have a high rugged avalanche characteristics. This power MOSFET is usually used at high speed switching applications in power supplies .PWM motor controls, high efficient DC to DC converters and bridge circuits.

■ Features

- $R_{DS(ON)}=1.2\Omega@V_{GS}=10V$
- Ultra Low gate charge(typical 28nC)
- Low reverse transfer capacitance(C_{rss} =typical 12.0pF)
- Fast switching capability
- Avalanche energy tested
- Improved dv/dt capability,high ruggedness

■ Symbol



■ Ordering Information

Order Number		Package	Pin Assignment			Packing
Normal	Lead Free Plating		1	2	3	
HX8N60-TA3-T	HX8N60L-TA3-T	TO-220	G	D	S	Tube
HX8N60-TF3-T	HX8N60L-TF3-T	TO-220F	G	D	S	Tube

Note:Pin Assignment: G:Gate D:Drain S:Source

	(1) T:Tube,R:Tape Reel
	(2) TA3:TO-220,TF3:TO-220F
	(3) L:Lead Free Plating Blank: Pb/Sn

■ Absolute Maximum Ratings($T_c=25^\circ\text{C}$,unless otherwise specified)

Parameter		Symbol	Ratings		Units
			TO-220	TO-220F	
Drain-Source Voltage		V_{DS}	600		V
Gate-Source Voltage		V_{GS}	± 30		V
Drain Current Continuous	$T_c=25^\circ\text{C}$	I_D	7.6	7.6*	A
	$T_c=100^\circ\text{C}$		4.7	4.7*	A
Drain Current Pulsed (Note 1)		I_{DP}	30	30*	A
Avalanche Energy	Repetitive (Note 1)	E_{AR}	14.7		mJ
	Single Pulse (Note 2)	E_{AS}	230		mJ
Peak Diode Recovery dv/dt (Note 3)		dv/dt	4.5		V/ns
Total Power Dissipation	$T_c=25^\circ\text{C}$	P_D	142	48	W
	Derate above 25°C		1.14	0.40	W/ $^\circ\text{C}$
Junction Temperature		T_J	+150		$^\circ\text{C}$
Storage Temperature		T_{STG}	-55~+150		$^\circ\text{C}$

* Drain current limited by maximum junction temperature.

■ Thermal Characteristics

Parameter	Symbol	Ratings		Units
		TO-220	TO-220F	
Thermal Resistance Junction-Ambient	R_{thJA}	62.5		°C/W
Thermal Resistance, Case-to-Sink Typ.	R_{thCS}	0.5	--	
Thermal Resistance Junction-Case	R_{thJC}	0.85	2.6	

■ Electrical Characteristics (T_J=25°C, unless Otherwise specified.)

Parameter		Symbol	Test Conditions	Min	Typ	Max	Units
Off Characteristics							
Drain-Source Breakdown Voltage		BV _{DSS}	V _{GS} =0V,I _D =250μA	600	--	--	V
Zero Gate Voltage Drain Current		I _{DSS}	V _{DS} =600V,V _{GS} =0V	--	--	1	μA
			V _{DS} =480V,T _C =125℃	--	--	10	μA
Gate-Body Leakage Current	Forward	I _{GSS}	V _{GS} =30V,V _{DS} =0V	--	--	100	nA
	Reverse		V _{GS} =-30V,V _{DS} =0V	--	--	-100	nA
Breakdown Voltage Temperature Coefficient		△BV _{DSS} /△T _J	I _D =250μA	--	0.7	--	V/℃
On Characteristics							
Gate Threshold Voltage		V _{GS(TH)}	V _{DS} =V _{GS} , I _D =250μA	2.0	--	4.0	V
Static Drain-Source On-Resistance		R _{DS(ON)}	V _{DS} =10V,I _D =3.8A	--	1.0	1.2	Ω
Dynamic Characteristics							
Input Capacitance		C _{ISS}	V _{DS} =25V,V _{GS} =0V, f=1MHz	--	--	1255	pF
Output Capacitance		C _{OSS}		--	--	135	pF
Reverse Transfer Capacitance		C _{RSS}		--	--	16	pF
Switching Characteristics							
Turn-On Delay Time		t _{D(ON)}	V _{DD} =300V,I _D =7.6A, R _G =25Ω (Note 4, 5)	--	--	45	ns
Rise Time		t _r		--	--	130	ns
Turn-Off Delay Time		t _{D(OFF)}		--	--	170	ns
Fall Time		t _f		--	--	140	ns
Total Gate Charge		Q _G	V _{DS} =480V, I _D =7.6A V _{GS} =10V (Note 4, 5)	--	28	36	nC
Gate-Source Charge		Q _{GS}		--	4.5	--	nC
Gate-Drain Charge		Q _{GD}		--	12	--	nC
Drain-Source Diode Characteristics							
Drain-Source Diode Forward Voltage		V _{SD}	V _{GS} =0V,I _{SD} =7.6A	--	--	1.4	V
Continuous Drain-Source Current		I _{SD}		--	--	7.6	A
Pulsed Drain-Source Current		I _{SM}		--	--	30	A
Reverse Recovery Time		t _{RR}	I _{SD} =7.6A, dI _{SD} /dt=100A/μs (Note 4)	--	365	--	ns
Reverse Recovery Charge		Q _{RR}		--	3.4	--	μC

Notes:

1. Repetitive Rating : Pulse width limited by maximum junction temperature
2. L = 7.3 mH, $I_{AS}=7.6A$, $V_{DD}=50V$, $R_G=25\Omega$, Starting $T_J=25^\circ C$
3. $I_{SD}\leq 7.6A$, $di/dt \leq 200A/\mu s$, $V_{DD}\leq BV_{DSS}$, Starting $T=25^\circ C$
4. Pulse Test : Pulse width $\leq 300\mu s$, Duty cycle $\leq 2\%$
5. Essentially independent of operating temperature

Typical Characteristics

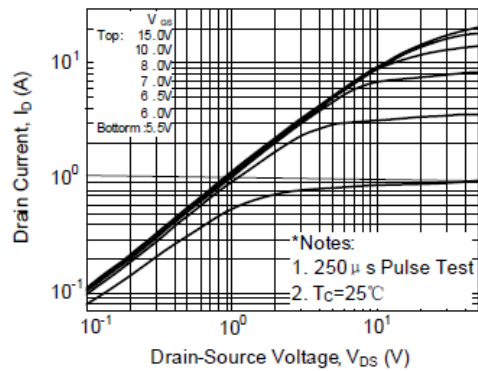


Figure 1. On-Region Characteristics

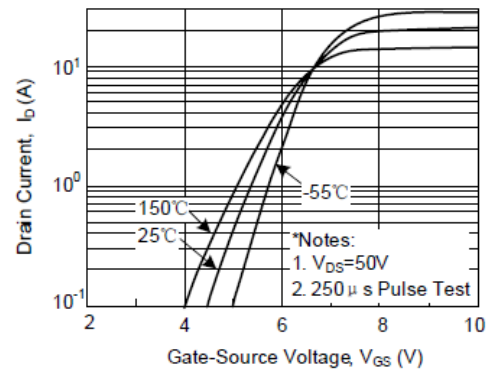


Figure 2. Transfer Characteristics

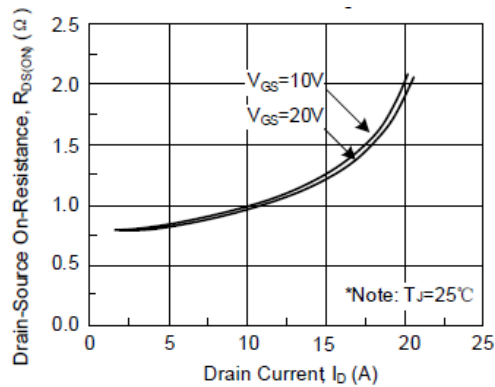


Figure 3. On-Resistance Variation vs Drain Current and Gate Voltage

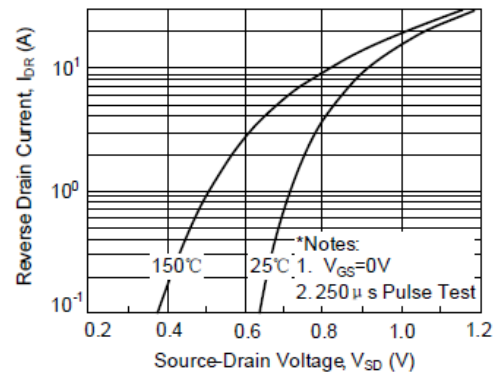


Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature

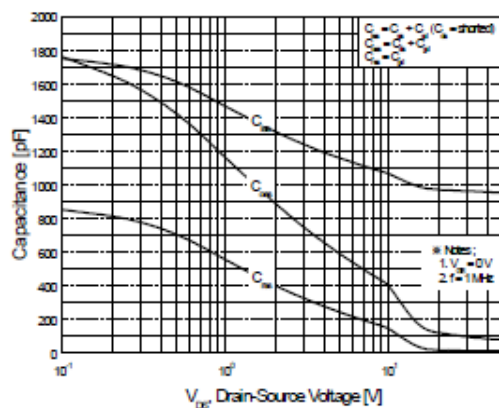


Figure 5. Capacitance Characteristics

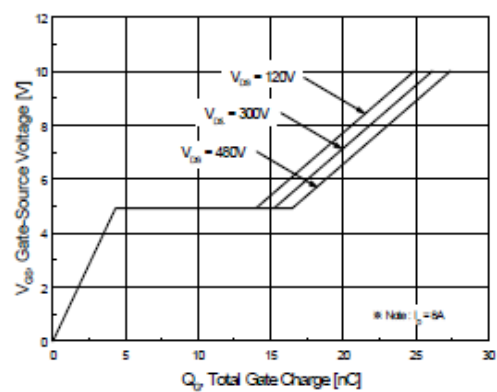


Figure 6. Gate Charge Characteristics

■ Typical Characteristics (Continued)

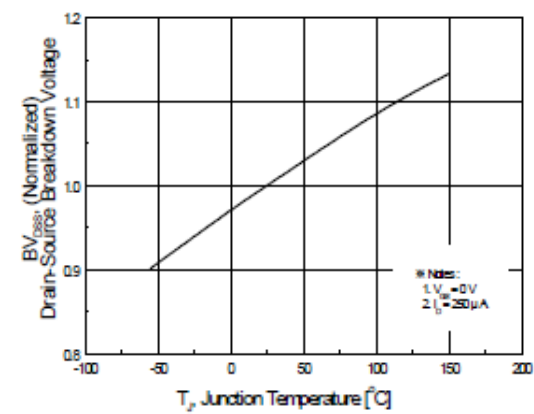


Figure 7. Breakdown Voltage Variation

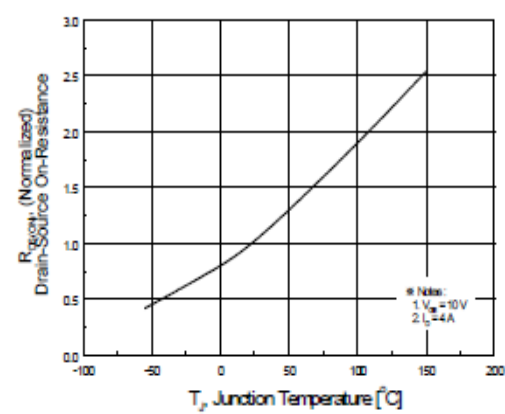


Figure8. On-Resistance Variation vs Temperature

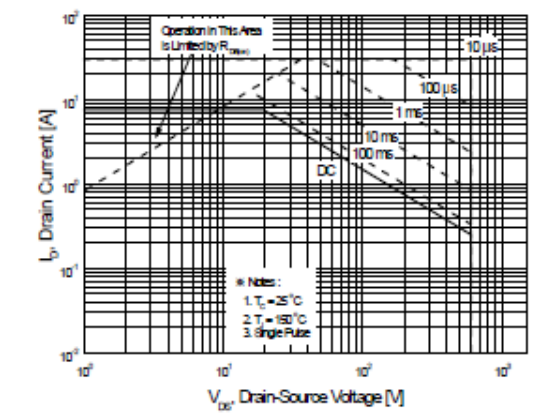


Figure 9-1. Maximum Safe Operating Area for TO220

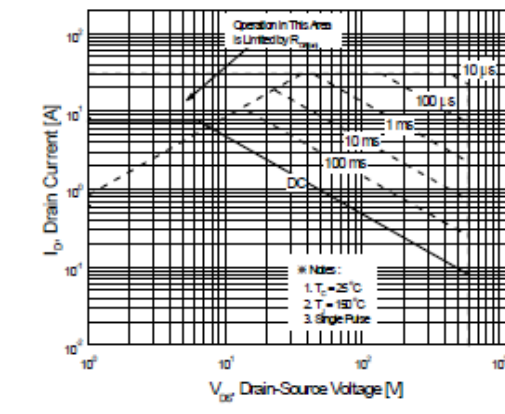


Figure 9-2. Maximum Safe Operating Area for TO220F

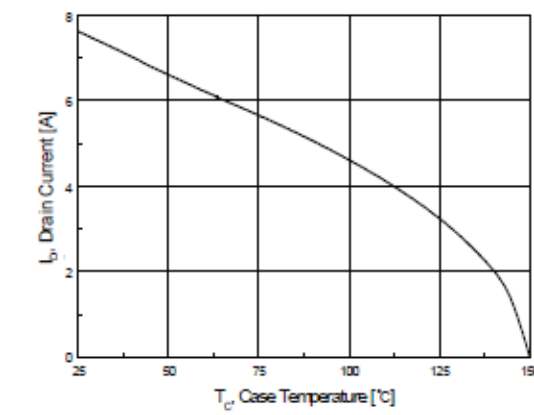


Figure 10. Maximum Drain Current vs Case Temperature

■ Typical Characteristics (Continued)

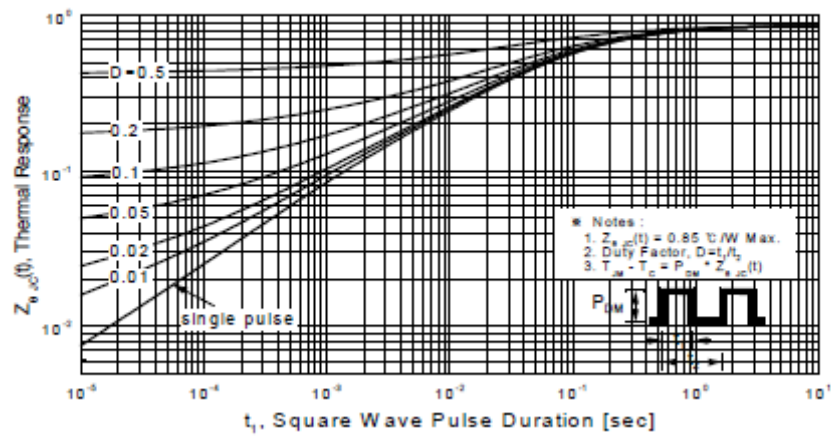


Figure 11-1. Transient Thermal Response Curve for TO220

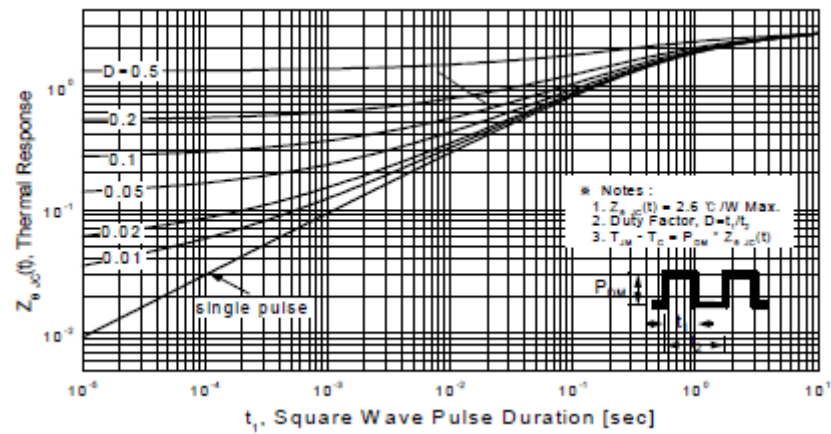


Figure 11-2. Transient Thermal Response Curve for TO220F